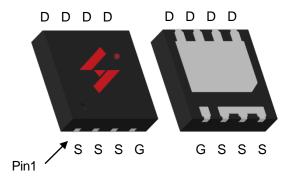


Single N-Channel Enhancement Mode MOSFET

Feature

- 30V/55A $R_{DS(ON)}=3.3m\Omega(typ.)$ @Vgs = 10V $R_{DS(ON)}=4.3$ $m\Omega(typ.)$ @Vgs = 4.5V
- 100% Avalanche Tested
- Reliable and Rugged
- Halogen Free and Green Devices Available (RoHS Compliant)

Pin Description



DFN3*3-8L

Applications

- Power Management for DC/DC
- Switching Application
- Battery Protection



Single N-Channel MOSFET

Ordering and Marking Information



Package Code

C1: DFN3*3-8L

Date Code XYMXXXXX

Note:HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nationfinish; which are fully compliant with RoHS.HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature.HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Ra	tings (Tc=25°C Unless Otherwise Noted)		•	
VDSS	Drain-Source Voltage		30	V
Vgss	Gate-Source Voltage		±20	V
TJ	Junction Temperature Range		-55 to 175	°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode) Tc=25°C		55	А
Mounted on	Large Heat Sink		-	•
Ірм	Pulsed Drain Current *	Tc=25°C	220	А
	Out to a Paris Out of	Tc=25°C	55	А
lо	Continuous Drain Current	Tc=100°C	38.8	А
Б	M : 5 5: : ::	Tc=25°C	23	W
PD	P _D Maximum Power Dissipation Tc=100°C		11.5	W
R ₀ JC	Thermal Resistance, Junction-to-Case		6.5	°C/W
$R_{ heta extsf{A}}$	Thermal Resistance, Junction-to-Ambient **		75	°C/W
Eas	SinglePulsed-Avalanche Energy ***	L=0.3mH	150	mJ

Note: * Repetitive rating; pulse width limited by max.junction temperature.
** Surface mounted on 1in2 FR-4 board.

Limited by TJmax , starting TJ=25°C, L = 0.1mH, Rg= 25Ω , VGS =10V.

Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

Cymbal	Parameter Test Conditions		HYC	HYG032N03LR1		
Symbol	Parameter	rest Conditions	Min	Тур.	Max	Unit
Static Cha	racteristics					
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250μA	30	-		V
Inco	Drain to Source Leekage Current	VDS=30V,VGS=0V	-	-	1	μΑ
IDSS	Drain-to-Source Leakage Current	TJ=125°C	-	-	50	μA
VGS(th)	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250µA	1.2	1.8	2.5	V
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =20A		3.3	4.5	mΩ
NDS(ON)	Diani-Source On-State Resistance	V _{GS} =4.5V,I _{DS} =20A		4.3	5.5	mΩ
Diode Characteristics						
Vsp*	Diode Forward Voltage	IsD=20A,Vgs=0V	-	0.8	1.2	V
trr	Reverse Recovery Time	las 200 dlas/dt 1000/ug	-	16	-	ns
Qrr	Reverse Recovery Charge	- Isb=20A,dIsb/dt=100A/μs	-	9	-	nC

HYG032N03LR1C1



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Combal	Barranatan	Toot Conditions	HY	HYG032N03LR1		
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Dynamic (Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V, Frequency=1.0MHz	-	2	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	2872	-	
Coss	Output Capacitance	Vps=25V,	-	332	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	277	-	
td(ON)	Turn-on Delay Time		-	11	-	
Tr	Turn-on Rise Time	$V_{DD}=15V,R_{G}=4\Omega,$	-	50	-	200
td(OFF)	Turn-off Delay Time	IDS=20A,VGS=10V	-	52	-	ns
Tf	Turn-off Fall Time		-	57	-	
Gate Char	Gate Charge Characteristics					
Qg(10V)	Total Gate Charge			61		
Qg(4.5V)	Total Gate Charge	$V_{DS} = 24V, V_{GS} = 10V,$	-	32	-	~C
Qgs	Gate-Source Charge	I _D =20A	-	10	-	nC
Qgd	Gate-Drain Charge		-	16	-	

Note: *Pulse test, pulse width ≤ 300 us, duty cycle $\leq 2\%$



Typical Operating Characteristics

Figure 1: Power Dissipation

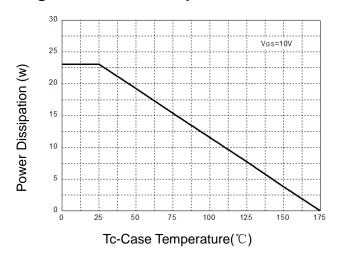


Figure 3: Safe Operation Area

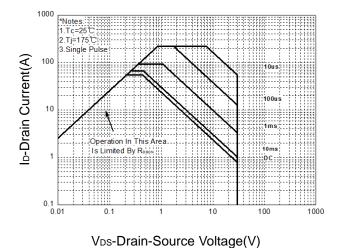


Figure 5: Output Characteristics

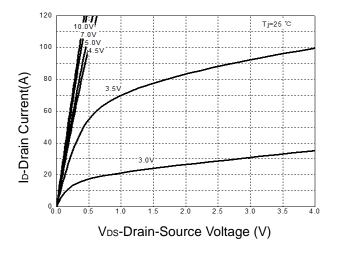


Figure 2: Drain Current

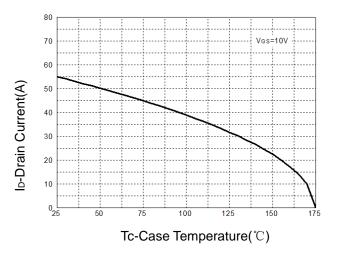
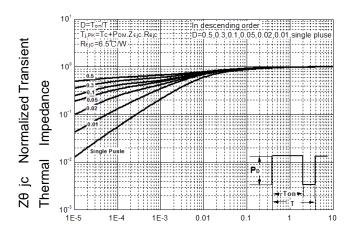
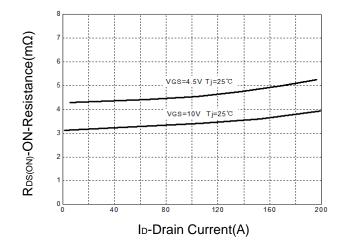


Figure 4: Thermal Transient Impedance



Maximum Effective Transient Thermal Impedance, Junction-to-Case

Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

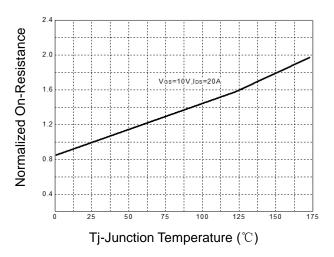


Figure 9: Capacitance Characteristics

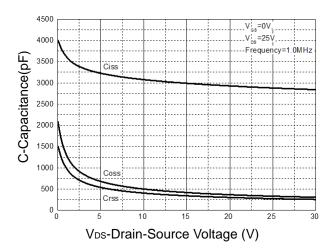


Figure 8: Source-Drain Diode Forward

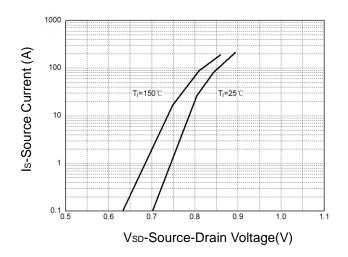
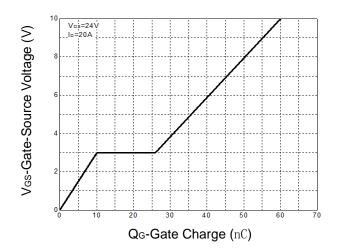
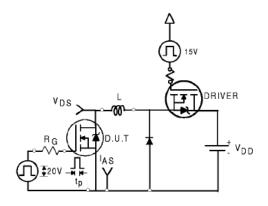


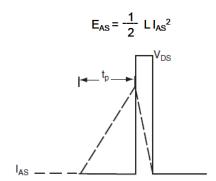
Figure 10: Gate Charge Characteristics



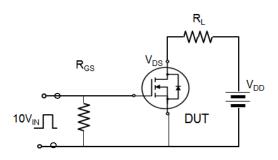


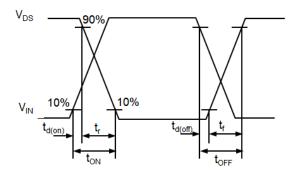
Avalanche Test Circuit



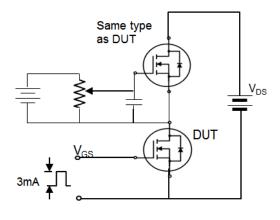


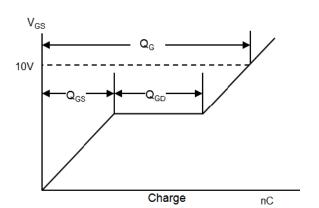
Switching Time Test Circuit





Gate Charge Test Circuit





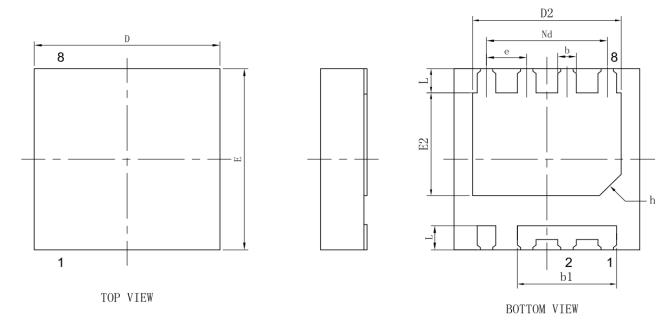


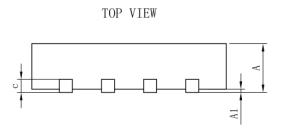
Device Per Unit

Package Type	Unit	Quantity
DFN3*3-8L	Reel	3000

Package Information

DFN3*3-8L





2,4,5,2,	MILLIMETER			
SYMBOL	MIN	NOM	MAX	
А	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
b	0.25	0.30	0.35	
b1	1.55	1.60	165.00	
С	0.19	0.20	0.21	
D	2.90	3.00	3.10	
D2	2.30	2.40	2.50	
Nd	1.90	1.95	2.00	
E	2.90	3.00	3.10	
E2	1.60	1.70	1.80	
е	0.65bsc			
L	0.35	0.40	0.45	
h	0.30	0.35	0.40	



Classification Profile



Classification Reflow Profiles

Sn-Pb Eutectic Assembly	Pb-Free Assembly
100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds
3 °C/second max.	3°C/second max.
183 °C 60-150 seconds	217 °C 60-150 seconds
See Classification Temp in table 1	SeeClassification Tempin table 2
20** seconds	30** seconds
6 °C/second max.	6 °C/second max.
6 minutes max.	8 minutes max.
	100 °C 150 °C 60-120 seconds 3 °C/second max. 183 °C 60-150 seconds See Classification Temp in table 1 20** seconds 6 °C/second max.

^{*}Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

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Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 /500/1000 Hrs, Vgs100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

Customer Service

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